

Dual N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A)	Q _g (Typ.)		
100	$0.567 \text{ at V}_{GS} = 10 \text{ V}$	2.5	2.2 nC		

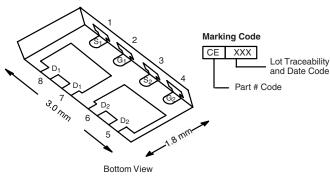
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN

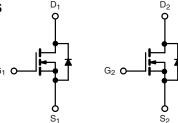
PowerPAK® ChipFET Dual



Ordering Information: Si5980DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Load Supply
- Power Supply



N-Channel MOSFET

N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	100	V	
Gate-Source Voltage	V _{GS}	± 20	v	
	T _C = 25 °C		2.5	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	2.0	
Continuous Diam Current (1) = 100 O)	T _A = 25 °C	'U	1.3 ^{b, c}	
	T _A = 70 °C		1.0 ^{b, c}	А
Pulsed Drain Current		I _{DM}	3	^
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	6 ^a	
Continuous Source-Diam blode Current	T _A = 25 °C	'5	1.7 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	2	
Avalanche Energy	L = 0.111111	E _{AS}	0.2	mJ
	T _C = 25 °C		7.8	
Maximum Power Dissipation	T _C = 70 °C	P _D	5.0	w
Maximum rower bissipation	T _A = 25 °C	, р	2.0 ^{b, c}	• • • • • • • • • • • • • • • • • • • •
	T _A = 70 °C		1.3 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature	· ·	260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	49	61	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	13	16]		

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c t = 5 s
- d. See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 110 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-					l
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		112		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.3		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2		4	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	1		1	
		V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 3 \text{ V}, V_{GS} = 10 \text{ V}$	3			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 0.4 \text{ A}$		0.472	0.567	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 20 V, I _D = 1.3 A		2		S
Dynamic ^b						
Input Capacitance	C _{iss}			78		pF
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		11		
Reverse Transfer Capacitance	C _{rss}			4		
Total Gate Charge	Qg			2.2	3.3	
Gate-Source Charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 1.3 \text{ A}$		1.0		nC
Gate-Drain Charge	Q _{gd}			0.4		
Gate Resistance	R _g	f = 1 MHz	0.5	2.4	4.8	Ω
Turn-On Delay Time	t _{d(on)}			7	14	
Rise Time	t _r	V_{DD} = 50 V, R_L = 50 Ω		10	20	-
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		7	14	
Fall Time	t _f			8	16	
Turn-On Delay Time	t _{d(on)}			8	16	ns
Rise Time	t _r	V_{DD} = 50 V, R_L = 50 Ω		11	20	-
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1 A, V_{GEN} = 7.5 V, R_g = 1 Ω		8	16	
Fall Time	t _f			9	18	
Drain-Source Body Diode Characteristi	cs				L	L
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			6	
Pulse Diode Forward Current	I _{SM}				3	Α
Body Diode Voltage	V_{SD}	I _S = 1 A, V _{GS} = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			22	33	ns
Body Diode Reverse Recovery Charge	ode Reverse Recovery Charge Q_{rr} $I_F = 1 \text{ A, dI/dt} = 100 \text{ A/µs, T}_J = 25 ^{\circ}\text{C}$			20	30	nC
everse Recovery Fall Time t_a everse Recovery Rise Time t_b t_b		$_{1F} = 1$ A, $_{1J} = 25$ C		15		ne
			7		- ns	

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

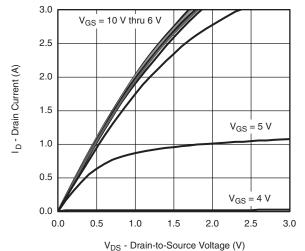
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



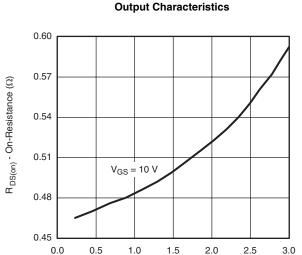




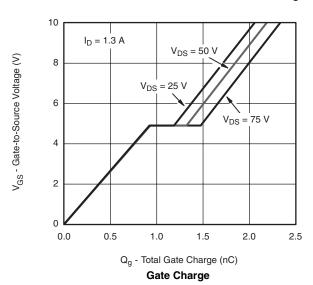
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

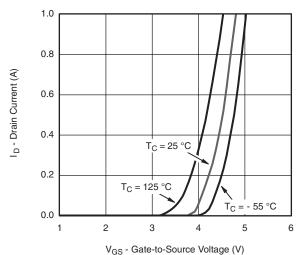


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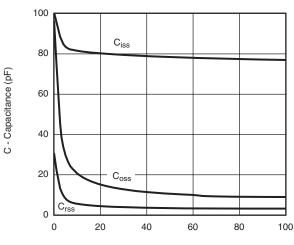


 $\label{eq:loss_problem} I_D \text{ - Drain Current (A)}$ On-Resistance vs. Drain Current and Gate Voltage

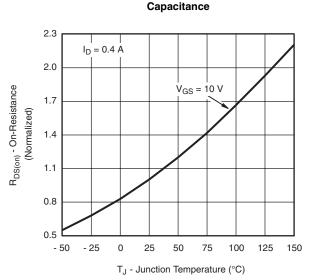




Transfer Characteristics



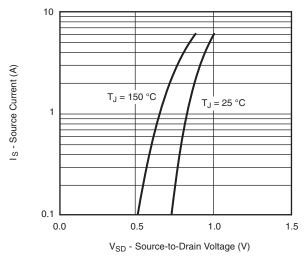
V_{DS} - Drain-to-Source Voltage (V)



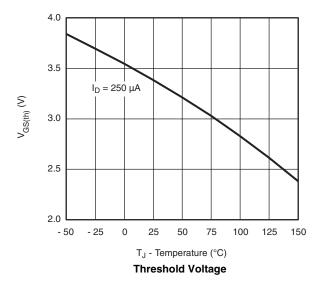
On-Resistance vs. Junction Temperature

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

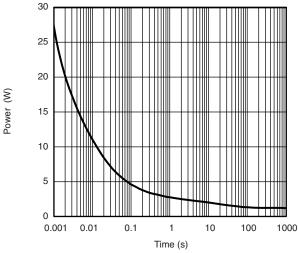


Source-Drain Diode Forward Voltage

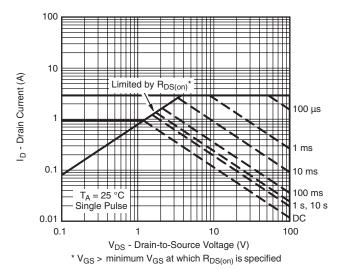


 $I_{D} = 0.4 \text{ A}$ $I_{D} = 0.4 \text{ A}$ $I_{J} = 125 \text{ °C}$ $T_{J} = 25 \text{ °C}$ 0.0 $4 \quad 5 \quad 6 \quad 7 \quad 8 \quad 9 \quad 10$

 $\label{eq:VGS} \mbox{V}_{GS} \mbox{ - Gate-to-Source Voltage (V)}$ On-Resistance vs. Gate-to-Source Voltage



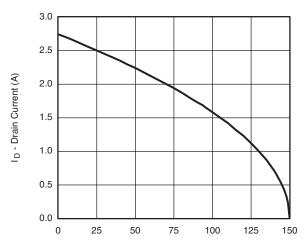
Single Pulse Power, Junction-to-Ambient





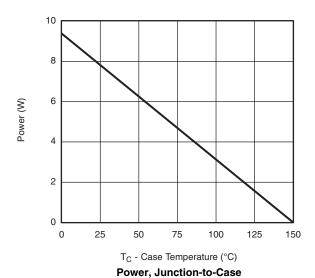


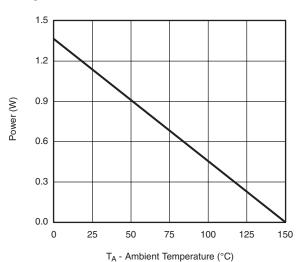
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





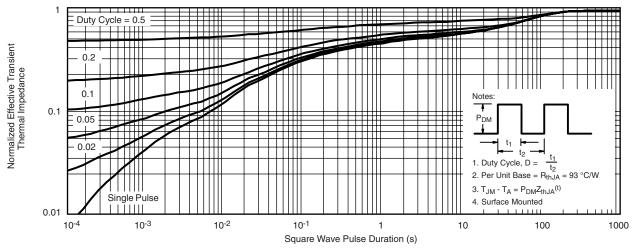
Power, Junction-to-Ambient

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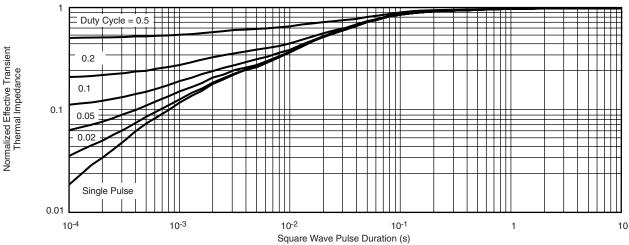
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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